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|-----------------------------------|---------------------------------------|--------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 10/743,913 | Applicant(s)/Patent Under Reexamination CHEN, CHAO-LIN | |
| | Examiner Gary Hartmann | Art Unit 3671 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|--------------------|----------------|
| | A | US-6,474,900 | 11-2002 | Feng, Pin-Chieh | 403/322.4 |
| | B | US-4,919,379 | 04-1990 | Goetz, Kurt A. | 24/521 |
| | C | US-4,809,724 | 03-1989 | Fuser, Anacleto | 135/16 |
| | D | US-4,711,422 | 12-1987 | Ibanez, Rene L. | 248/515 |
| | E | US-2,822,143 | 02-1958 | JOHANSEN MILDRED C | 248/516 |
| | F | US-2,455,258 | 11-1948 | BENJAMIN LEVITIN | 24/501 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|----------------|---------------|----------------|
| | N | 2 277 955 | 11-1994 | United Kingdom | Rodger et al. | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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